DIM375WHS06-S000

Half Bridge IGBT Module

FEATURES

- Low Forward Voltage Drop
- Isolated Copper Baseplate

APPLICATIONS

- Inverters
- Motor Controllers

The Powerline range of modules includes half bridge, chopper, bi-directional, dual and single switch configurations covering voltages from 600V to 3300V and currents up to 3600A.

The DIM375WHS06-S000 is a half bridge 600V n channel enhancement mode insulated gate bipolar transistor (IGBT) module. The module is suitable for a variety of medium voltage applications in motor drives and power conversion.

The IGBT has a wide reverse bias safe operating area (RBSOA) for ultimate reliability in demanding applications.

These modules incorporate electrically isolated base plates and low inductance construction enabling circuit designers to optimise circuit layouts and utilise earthed heat sinks for safety.

Typical applications include dc motor drives, ac pwm drivesand ups systems..

ORDERING INFORMATION

Order as: **DIM375WHS06-S000**

Note: When ordering, use complete part number.

KEY PARAMETERS

V_{CES}		600V
$V_{CE(sat)}$*	(typ)	2.1V
I_C	(max)	375A
$I_{C(PK)}$	(max)	750A

*(measured at the power busbars and not the auxiliary terminals)
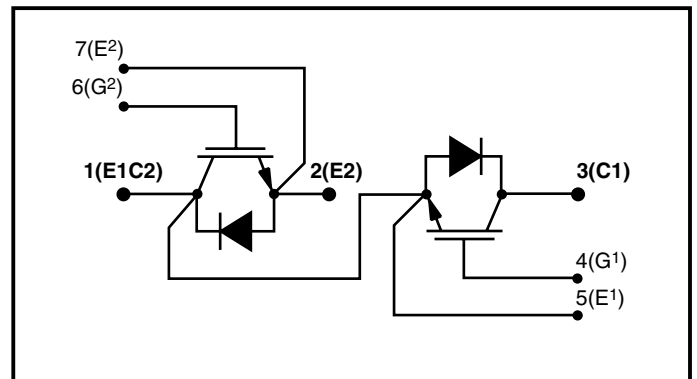

Fig. 1 Half bridge circuit diagram

Outline type code: W

(See package details for further information)

Fig. 2 Electrical connections - (not to scale)

Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures.

ABSOLUTE MAXIMUM RATINGS - PER ARM

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25˚C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V_{CES}	Collector-emitter voltage	V_{GE} = 0V	600	V
V_{GES}	Gate-emitter voltage	-	±20	V
I_C	Continuous collector current	T_{case} = 65˚C	375	A
$I_{C(PK)}$	Peak collector current	1ms, T_{case} = 95˚C	750	A
P_{max}	Max. transistor power dissipation	T_{case} = 25˚C, T_j = 150˚C	1736	W
I^2t	Diode I^2t value	V_R = 0, t_p = 10ms, T_{vj} = 125˚C	TBD	kA^2s
V_{isol}	Isolation voltage - per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2.5	kV

THERMAL AND MECHANICAL RATINGS

Internal insulation: Al_2O_3
Baseplate material: Cu
Creepage distance: 24mm

Clearance: 13mm
CTI (Critical Tracking Index): 175

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$R_{th(j-c)}$	Thermal resistance - transistor	Continuous dissipation - junction to case	-	-	72	˚C/kW
$R_{th(j-c)}$	Thermal resistance - diode	Continuous dissipation - junction to case	-	-	135	˚C/kW
$R_{th(c-h)}$	Thermal resistance - case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	15	˚C/kW
T_j	Junction temperature	Transistor	-	-	150	˚
		Diode	-	-	125	˚
T_{stg}	Storage temperature range	-	−40	-	125	˚
-	Screw torque	Mounting - M6	3	-	5	Nm
		Electrical connections - M6	2.5	-	5	Nm

2/8   Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures.

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ELECTRICAL CHARACTERISTICS

T_{case} = 25˚C unless stated otherwise.

| Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
I_{CES}	Collector cut-off current	V_{GE} = 0V, V_{CE} = V_{CES}	-	-	2	mA
		V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125˚C	-	-	10	mA
I_{GES}	Gate leakage current	V_{GE} = ±20V, V_{CE} = 0V	-	-	2	μA
$V_{GE(TH)}$	Gate threshold voltage	I_C = 15mA, V_{GE} = V_{CE}	4.5	5.5	7.5	V
$V_{CE(sat)}$†	Collector-emitter saturation voltage	V_{GE} = 15V, I_C = 350A	-	2.1	2.6	V
		V_{GE} = 15V, I_C = 350A, , T_{case} = 125˚C	-	2.3	2.8	V
I_F	Diode forward current	DC	-	-	375	A
I_{FM}	Diode maximum forward current	t_p = 1ms	-	-	750	A
V_F†	Diode forward voltage	I_F = 350A	-	1.5	1.8	V
		I_F = 350A, T_{case} = 125˚C	-	1.5	1.8	V
C_{ies}	Input capacitance	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz	-	40	-	nF
L_M	Module inductance	-	-	20	-	nH
R_{INT}	Internal transistor resistance - per arm	-	-	0.23		mΩ

Note:

† Measured at the power busbars and not the auxiliary terminals.

L* is the circuit inductance + L_M

ELECTRICAL CHARACTERISTICS

T_{case} = 25˚C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$t_{d(off)}$	Turn-off delay time	I_C = 375A	-	600	-	ns
t_f	Fall time	V_{GE} = ±15V	-	250	-	ns
E_{OFF}	Turn-off energy loss	V_{CE} = 300V	-	26	-	mJ
$t_{d(on)}$	Turn-on delay time	$R_{G(ON)}$ = $R_{G(OFF)}$ = 4.7Ω	-	200	-	ns
t_r	Rise time	L ~ 100nH	-	150	-	ns
E_{ON}	Turn-on energy loss		-	16	-	mJ
Q_g	Gate charge		-	3	-	µC
Q_{rr}	Diode reverse recovery charge	I_F = 375A, V_R = 300V,	-	20	-	µC
I_{rr}	Diode reverse current	dI_F/dt = 3000A/µs	-	200	-	A
E_{REC}	Diode reverse recovery energy		-	5	-	mJ

T_{case} = 125˚C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$t_{d(off)}$	Turn-off delay time	I_C = 375A	-	650	-	ns
t_f	Fall time	V_{GE} = ±15V	-	500	-	ns
E_{OFF}	Turn-off energy loss	V_{CE} = 300V	-	40	-	mJ
$t_{d(on)}$	Turn-on delay time	$R_{G(ON)}$ = $R_{G(OFF)}$ = 4.7Ω	-	200	-	ns
t_r	Rise time	L ~ 100nH	-	100	-	ns
E_{ON}	Turn-on energy loss		-	15	-	mJ
Q_{rr}	Diode reverse recovery charge	I_F = 375A, V_R = 300V,	-	30	-	µC
I_{rr}	Diode reverse current	dI_F/dt = 3000A/µs	-	230	-	A
E_{REC}	Diode reverse recovery energy		-	8	-	mJ

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TYPICAL CHARACTERISTICS

Fig.3 Typical output characteristics
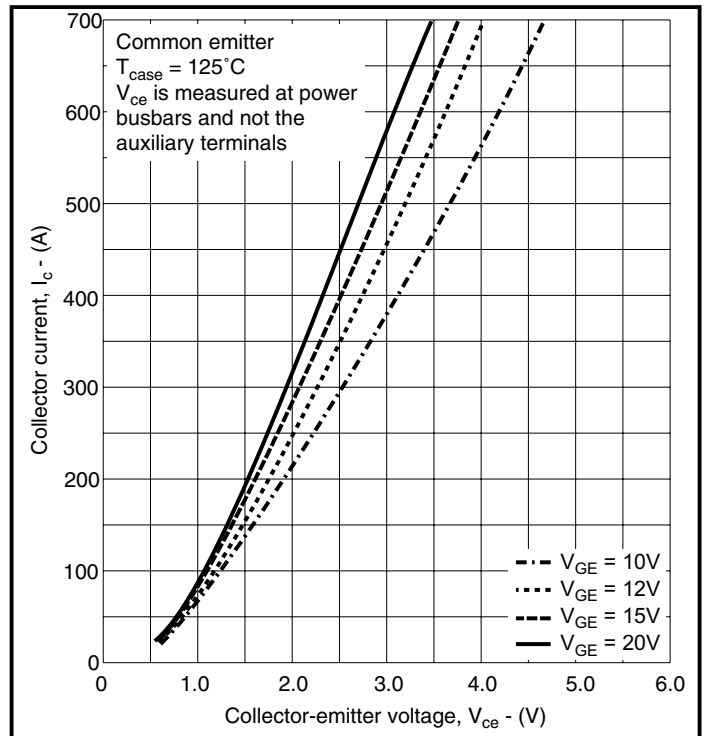
Fig.4 Typical output characteristics
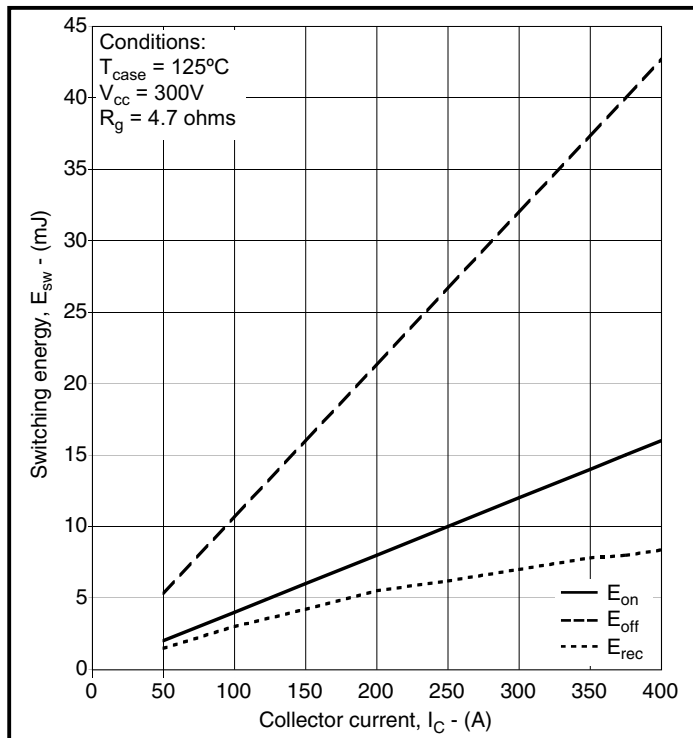
Fig.4 Typical switching energy vs collector current
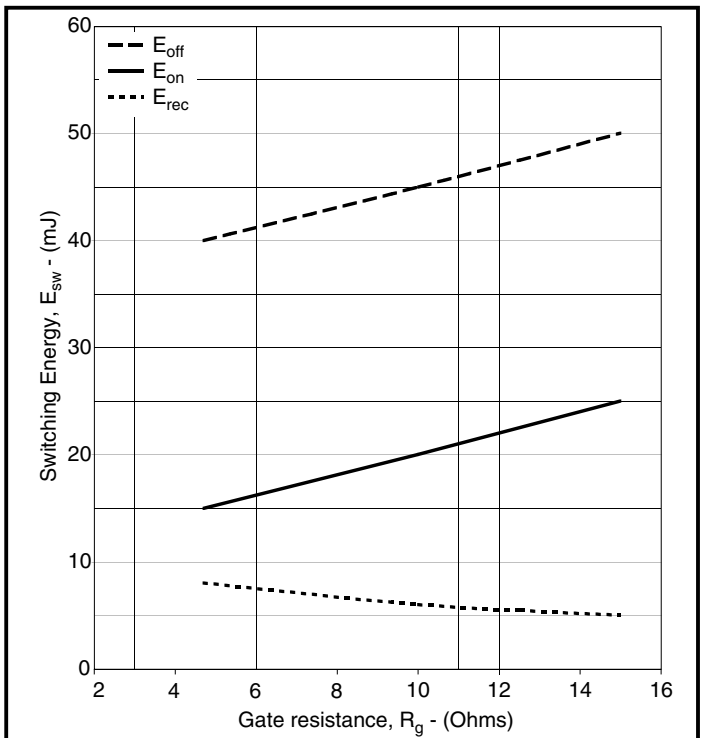
Fig.5 Typical switching energy vs gate resistance

Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures.
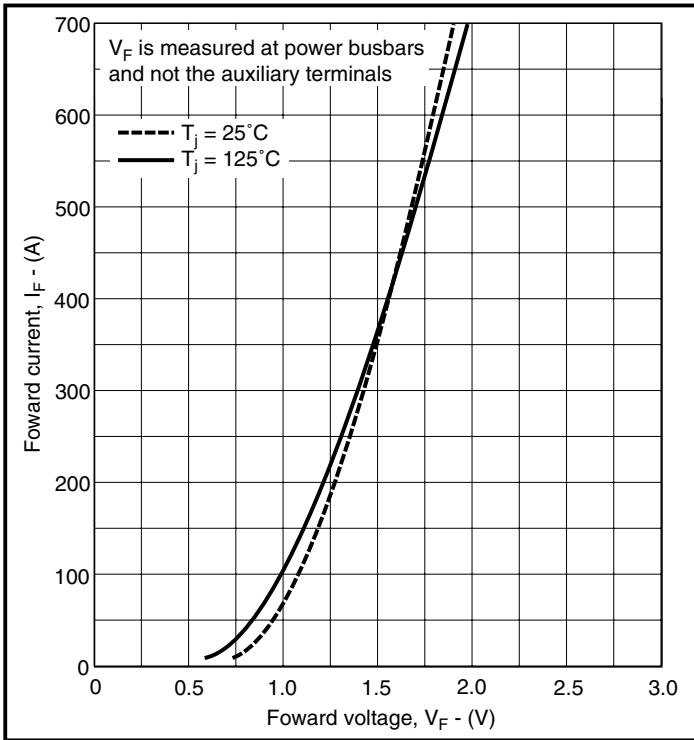
Fig.6 Diode typical forward characteristics
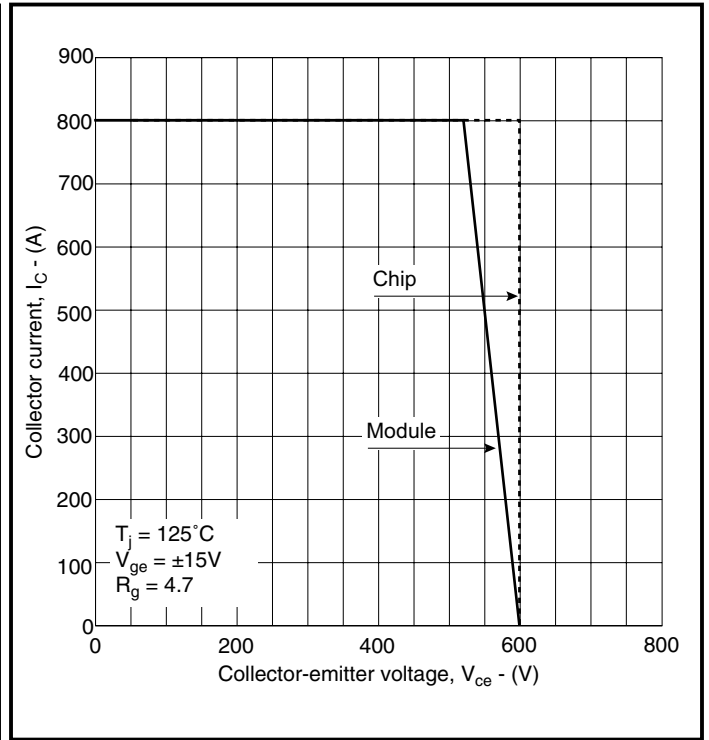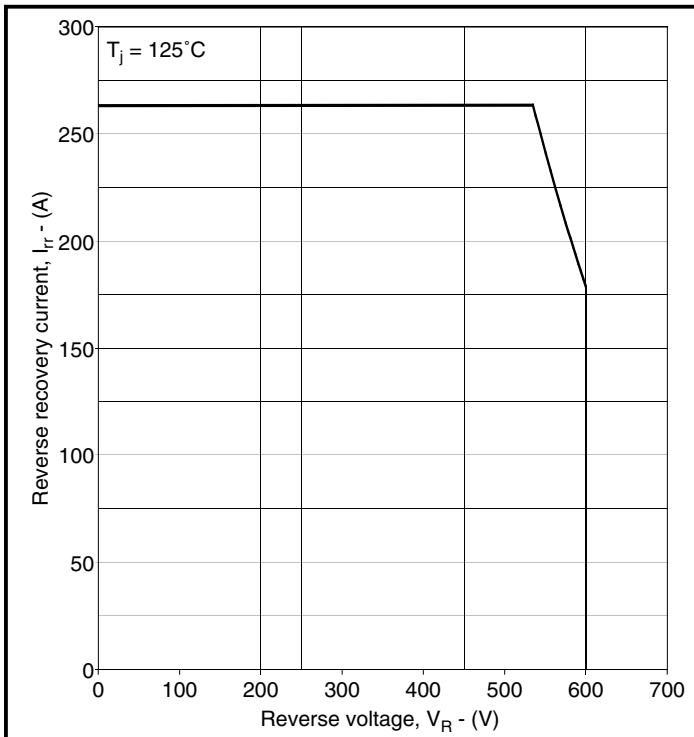

Fig.7 Reverse bias safe operating area

Fig.7 Diode reverse bias safe operating area
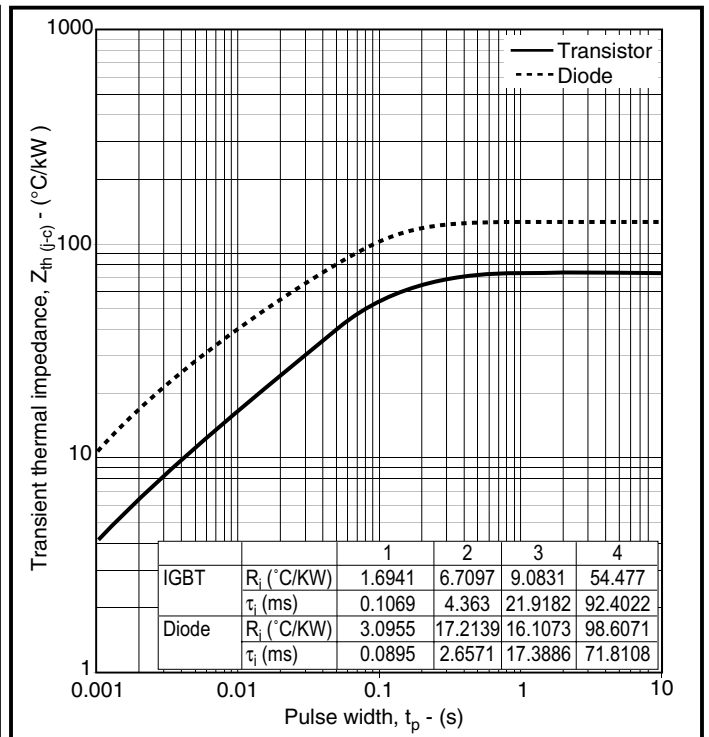
Fig.8 Transient thermal impedance

		1	2	3	4
IGBT	R_i (°C/KW)	1.6941	6.7097	9.0831	54.477
	τ_i (ms)	0.1069	4.363	21.9182	92.4022
Diode	R_i (°C/KW)	3.0955	17.2139	16.1073	98.6071
	τ_i (ms)	0.0895	2.6571	17.3886	71.8108

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.
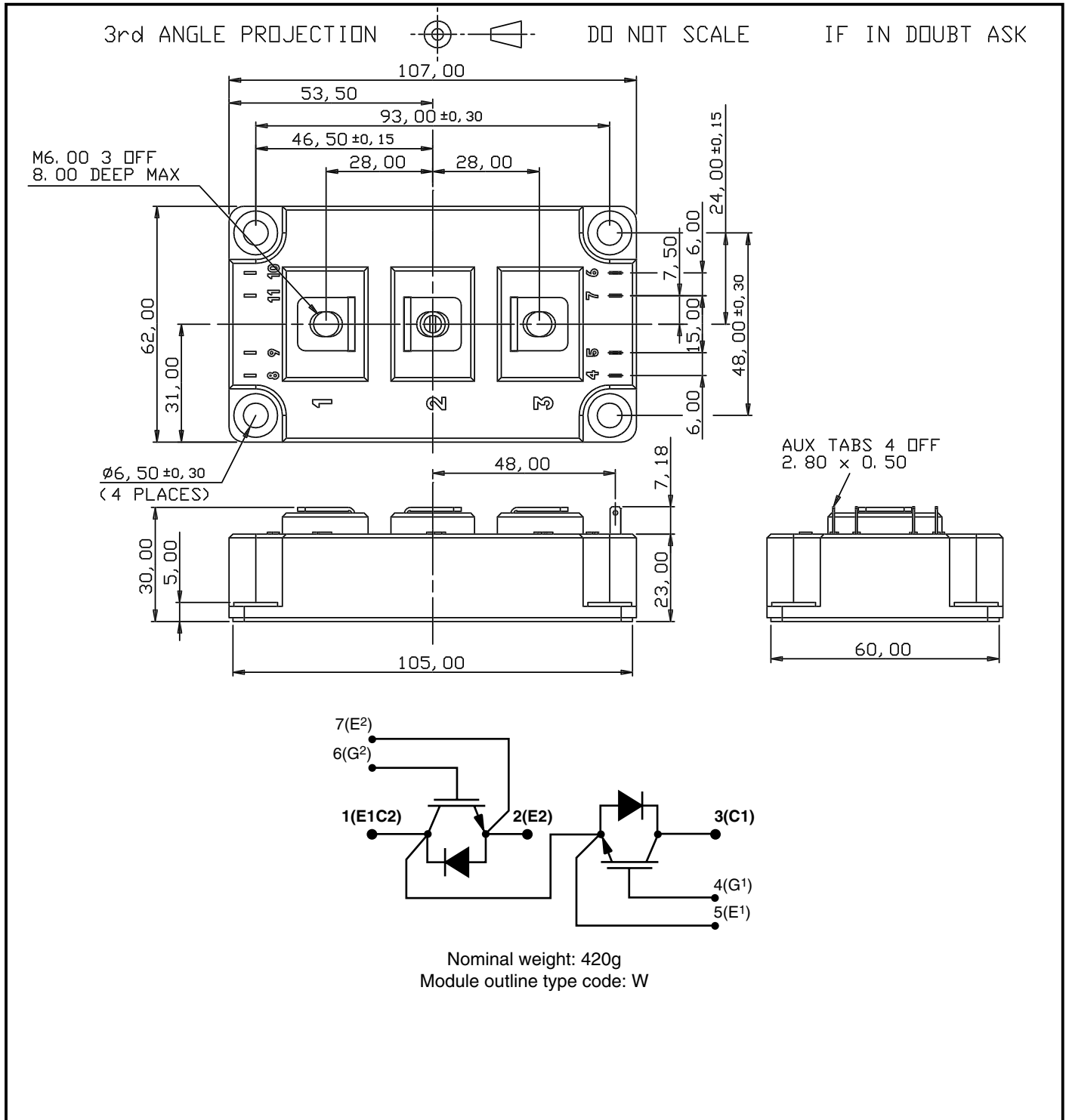
Fig. 15 Package details

Nominal weight: 420g
Module outline type code: W

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POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

HEATSINKS

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.